Application/Control No. Applicant(s)/Patent Under Reexamination 10/053,202 BAN ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Yuwen Pan 2682 U.S. PATENT DOCUMENTS **Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY Α US-6,625,478 09-2003 Nonogaki, Masaru 455/574 US-В US-С D US-US-Ε F US-G US-Н USı US-US-J Κ US-US-L М US-FOREIGN PATENT DOCUMENTS **Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Р Q R S T **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

W

Х